

Properties:

The IC scanner can be adapted with different ICR probes to measure E- and H-near fields. The probes can be moved above the chip surface in all three axes and around the z-axis. The scanner allows the user to check the position of the probe tip visually through a video microscope.

The scanner is controlled via PC with the ChipScan-Scanner software.

Axes	x	У	z	α-rotation
Max. measuring range	50 mm	50 mm	50 mm	+/- 180°
Accuracy	10 µm	10 µm	10 µm	1°
Repeatability	+/- 1 µm	+/- 1 μm	+/- 1 µm	+/- 1°
Speed	2 mm/s	2 mm/s	2 mm/s	45°/s
Control	USB			
Supply voltage	110 / 230 V			
Dimensions / total weight	(320 x 220 x 270) mm / 4.35 kg			

Software:	ChipScan-Scanner - zero position, manual or script-based probe movement - reading the data from a spectrum analyser - visualisation of the measuring results in 2D or 3D - output as csv and image files
Optional accessories:	- UH-DUT universal holder for receiving the electronics
Scope of delivery:	 ICS 105 IC scanner ICR near-field microprobes for E and H fields Video microscope with holder GND 25 ground plane ChipScan-Scanner software Flight case